

NTHE LINE STATES PATENT AND TRADEMARK OFFICE

Applicant: Shunpei Yamazaki, et al.

Art Unit : 2871

Serial No.: 09/126,826

Examiner: Dung T. Nguyen

Filed

: July 31, 1998

Title

: METHOD FOR PRODUCING DISPLAY DEVICE

## MAIL STOP RCE

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This filing is being made with the filing of a Request for Continued Examination. No fee is required.

Respectfully submitted,

Date: May 9, 2005

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RXD/adt 40278901.doc

Substitute Form PTO-1449 (Modified)

U.S. Department of Commerce Patent and Trademant Office Attorney's Docket No. 07977-019002

Application No. 09/126,826

Information Disclosure Statement

by Applicant (Use several sheets if necessary) way 0 9 2005

09/SI

Applicant Shunpei Yamazaki, et al.

Filing Date July 31, 1998

Group Art Unit 2871

(37 CFR §1.98(b)) July 31, 1998

				nt Documents			
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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-	AB	4,065,781	12/27/1977	Gutknecht			06/21/1974
	AC	4,068,020	01/10/1978	Reuschel			12/29/1975
	AD	4,103,297	07/25/1978	McGreivy et al.			12/20/1976
	AE	4,239,346	12/16/1980	Lloyd			05/23/1979
	AF	4,365,013	12/21/1982	Ishioka et al.			07/28/1981
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	AH	4,470,060	09/04/1984	Yamazaki			01/11/1982
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U.S. Department of Commerce

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(37 CFR §1.98(b))

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(37 CFR §1.98(b))

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Examiner	Desig.	Document	Publication	Country or		Sub-	Translation	
Initial	ID _	Number	Date	Patent Office	Class	class	Yes	No
	DQ	EP 231953	08/12/1987	JAPAN			In English	
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	DS	JP 55-032026	03/06/1980	JAPAN			Full	
	DT	JP 60-033863	02/21/1985	JAPAN			Abstract	
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-	DV	JP 60-066863	04/17/1985	JAPAN			Abstract	
	DW	JP 60-066865	04/17/1985	JAPAN			Abstract	
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	DY	JP 63-100777	05/02/1988	JAPAN			Abstract	
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	EA	JP 64-030272	02/01/1989	JAPAN	-		Abstract	

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(37 CFR §1.98(b))

Foreign Patent Dockments of Published Foreign Patent Applications Publication Translation Sub-Country or Desig. Document Examiner **Patent Office** Class class Yes No ID Number Date Initial EB JP 64-068724 03/14/1989 **JAPAN** Abstract Abstract EC 05/23/1989 **JAPAN** JP 01-130131 Full 06/20/1989 **JAPAN** ED JP 01-156725 **JAPAN** Abstract EE JP 02-051129 02/21/1990 Abstract **JAPAN EF** JP 02-103925 04/17/1990 07/24/1990 Abstract **JAPAN** EG JP 02-188723 Full 09/17/1990 **JAPAN** JP 02-234134 EH Abstract 07/01/1992 **JAPAN** JP 04-184424 ΕI Abstract 06/10/1994 **JAPAN** EJ JP 06-163958

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	EM						
	EN						

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